## MC145151-2 and MC145152-2

## PLL Frequency Synthesizers (CMOS)

The devices described in this document are typically used as low-power, phase-locked loop frequency synthesizers. When combined with an external low-pass filter and voltage-controlled oscillator, these devices can provide all the remaining functions for a PLL frequency synthesizer operating up to the device's frequency limit. For higher VCO frequency operation, a down mixer or a prescaler can be used between the VCO and the synthesizer IC.

These frequency synthesizer chips can be found in the following and other applications:



| Device | Package |
| :---: | :---: |
| MC145151P2 | Plastic DIP |
| MC145151DW2 | SOG Package |
| MC145152P2 | Plastic DIP |
| MC145152DW2 | SOG Package |

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## 1 MC145151-2 Parallel-Input (Interfaces with Single-Modulus Prescalers)

The MC145151-2 is programmed by 14 parallel-input data lines for the N counter and three input lines for the R counter. The device features consist of a reference oscillator, selectable-reference divider, digital-phase detector, and 14-bit programmable divide-by-N counter.
The MC145151-2 is an improved-performance drop-in replacement for the MC145151-1. The power consumption has decreased and ESD and latch-up performance have improved.

### 1.1 Features

- Operating Temperature Range: - 40 to $85^{\circ} \mathrm{C}$
- Low Power Consumption Through Use of CMOS Technology
- 3.0 to 9.0 V Supply Range
- On- or Off-Chip Reference Oscillator Operation
- Lock Detect Signal
- $\div$ N Counter Output Available
- Single Modulus/Parallel Programming
- 8 User-Selectable $\div$ R Values: 8, 128, 256, 512, 1024, 2048, 2410, 8192
- $\div$ N Range $=3$ to 16383
- "Linearized" Digital Phase Detector Enhances Transfer Function Linearity
- Two Error Signal Options: Single-Ended (Three-State) or Double-Ended
- Chip Complexity: 8000 FETs or 2000 Equivalent Gates

| $f _ { \text { in } } \longdiv { 1 }$ | 28 | ]LD |
| :---: | :---: | :---: |
| $\mathrm{v}_{\text {SS }}$ [2 | 27 | $\mathrm{ZOSC}_{\text {in }}$ |
| $\mathrm{V}_{\mathrm{DD}}[3$ | 26 | $\mathrm{JOSC}_{\text {out }}$ |
| $\mathrm{PD}_{\text {out }} 4$ | 25 | N11 |
| RAO[5 | 24 | N10 |
| RA1[6 | 23 | N13 |
| RA2 17 | 22 | N12 |
| $\phi_{R}[8$ | 21 | T/R |
| $\phi_{\mathrm{V}} \mathrm{C} 9$ | 20 | JN9 |
| $\mathrm{f}_{\mathrm{V}} \mathrm{L} 10$ | 19 | J8 |
| N0 11 | 18 | J7 |
| N1 12 | 17 | N6 |
| N2 13 | 16 | N5 |
| N3 14 | 15 | N4 |

Figure 1. MC145151-2 Pin Assignment


NOTE: N0 - N13 inputs and inputs RA0, RA1, and RA2 have pull-up resistors that are not shown.
Figure 2. MC145151-2 Block Diagram

### 1.2 Pin Descriptions

### 1.2.1 Input Pins

$f_{i n}$

## Frequency Input (Pin 1)

Input to the $\div \mathrm{N}$ portion of the synthesizer. $\mathrm{f}_{\mathrm{in}}$ is typically derived from loop VCO and is ac coupled into the device. For larger amplitude signals (standard CMOS logic levels) dc coupling may be used.
RAO - RA2

## Reference Address Inputs (Pins 5, 6, 7)

These three inputs establish a code defining one of eight possible divide values for the total reference divider, as defined by the table below.

Pull-up resistors ensure that inputs left open remain at a logic 1 and require only a SPST switch to alter data to the zero state.

| Reference Address Code |  | Total <br> Divide <br> Value |  |
| :---: | :---: | :---: | :---: |
| RA2 | RA1 | RA0 | 8 |
| 0 | 0 | 0 | 8 |
| 0 | 0 | 1 | 128 |
| 0 | 1 | 0 | 256 |
| 0 | 1 | 1 | 512 |
| 1 | 0 | 0 | 1024 |
| 1 | 0 | 1 | 2048 |
| 1 | 1 | 0 | 2410 |
| 1 | 1 | 1 | 8192 |

MC145151-2 and MC145152-2 Technical Data, Rev. 5

MC145151-2 Parallel-Input (Interfaces with Single-Modulus Prescalers)
NO - N11
N Counter Programming Inputs (Pins 11-20, 22-25)
These inputs provide the data that is preset into the $\div \mathrm{N}$ counter when it reaches the count of zero. N 0 is the least significant and N13 is the most significant. Pull-up resistors ensure that inputs left open remain at a logic 1 and require only an SPST switch to alter data to the zero state.

## T/R

Transmit/Receive Offset Adder Input (Pin 21)
This input controls the offset added to the data provided at the N inputs. This is normally used for offsetting the VCO frequency by an amount equal to the IF frequency of the transceiver. This offset is fixed at 856 when T/R is low and gives no offset when T/R is high. A pull-up resistor ensures that no connection will appear as a logic 1 causing no offset addition.

## OSC $_{\text {in }}$, OSC $_{\text {out }}$ Reference Oscillator Input/Output (Pins 27, 26)

These pins form an on-chip reference oscillator when connected to terminals of an external parallel resonant crystal. Frequency setting capacitors of appropriate value must be connected from $\mathrm{OSC}_{\text {in }}$ to ground and OSC $_{\text {out }}$ to ground. OSC $_{\text {in }}$ may also serve as the input for an externally-generated reference signal. This signal is typically ac coupled to $\mathrm{OSC}_{\mathrm{in}}$, but for larger amplitude signals (standard CMOS logic levels) dc coupling may also be used. In the external reference mode, no connection is required to OSC $_{\text {out }}$.

### 1.2.2 Output Pins

## PD ${ }_{\text {out }}$

Phase Detector A Output (Pin 4)
Three-state output of phase detector for use as loop-error signal. Double-ended outputs are also available for this purpose (see $\phi_{\mathrm{V}}$ and $\phi_{\mathrm{R}}$ ).
Frequency $f_{V}>f_{R}$ or $f_{V}$ Leading: Negative Pulses
Frequency $f_{V}<f_{R}$ or $f_{V}$ Lagging: Positive Pulses
Frequency $f_{V}=f_{R}$ and Phase Coincidence: High-Impedance State
$\phi_{\mathbf{R}}, \phi_{\mathbf{V}}$

## Phase Detector B Outputs (Pins 8, 9)

These phase detector outputs can be combined externally for a loop-error signal. A single-ended output is also available for this purpose (see $\mathbf{P D}_{\text {out }}$ ).
If frequency $f_{V}$ is greater than $f_{R}$ or if the phase of $f_{V}$ is leading, then error information is provided by $\phi_{V}$ pulsing low. $\phi_{\mathrm{R}}$ remains essentially high.

If the frequency $f_{V}$ is less than $f_{R}$ or if the phase of $f_{V}$ is lagging, then error information is provided by $\phi_{R}$ pulsing low. $\phi_{\mathrm{V}}$ remains essentially high.
If the frequency of $f_{V}=f_{R}$ and both are in phase, then both $\phi_{V}$ and $\phi_{R}$ remain high except for a small minimum time period when both pulse low in phase.

## $\mathrm{f}_{\mathrm{V}}$ <br> N Counter Output (Pin 10)

This is the buffered output of the $\div \mathrm{N}$ counter that is internally connected to the phase detector input. With this output available, the $\div \mathrm{N}$ counter can be used independently.

## LD <br> Lock Detector Output (Pin 28)

Essentially a high level when loop is locked ( $\mathrm{f}_{\mathrm{R}}, \mathrm{f}_{\mathrm{V}}$ of same phase and frequency). Pulses low when loop is out of lock.

### 1.2.3 Power Supply

$V_{D D}$
Positive Power Supply (Pin 3)
The positive power supply potential. This pin may range from +3 to +9 V with respect to $\mathrm{V}_{\mathrm{SS}}$.
$V_{\text {SS }}$
Negative Power Supply (Pin 2)
The most negative supply potential. This pin is usually ground.

## MC145151-2 Parallel-Input (Interfaces with Single-Modulus Prescalers)

### 1.3 Typical Applications



Figure 3. 5 MHz to 5.5 MHz Local Oscillator Channel Spacing $=1 \mathrm{kHz}$

2. Frequency values shown are for the $440-470 \mathrm{MHz}$ band. Similar implementation applies to the $406-440 \mathrm{MHz}$ band. For 470-512 MHz, consider reference oscillator frequency X9 for mixer injection signal ( 90.3750 MHz ).

Figure 4. Synthesizer for Land Mobile Radio UHF Bands

## 2 MC145152-2 Parallel-Input (Interfaces with Dual-Modulus Prescalers)

The MC145152-2 is programmed by sixteen parallel inputs for the N and A counters and three input lines for the R counter. The device features consist of a reference oscillator, selectable-reference divider, two-output phase detector, 10-bit programmable divide-by-N counter, and 6-bit programmable divide-by-A counter.

The MC145152-2 is an improved-performance drop-in replacement for the MC145152-1. Power consumption has decreased and ESD and latch-up performance have improved.

### 2.1 Features

- Operating Temperature Range: -40 to $85^{\circ} \mathrm{C}$
- Low Power Consumption Through Use of CMOS Technology
- 3.0 to 9.0 V Supply Range
- On- or Off-Chip Reference Oscillator Operation
- Lock Detect Signal
- Dual Modulus/Parallel Programming
- 8 User-Selectable $\div$ R Values: 8, 64, 128, 256, 512, 1024, 1160, 2048
- $\div \mathrm{N}$ Range $=3$ to $1023, \div$ A Range $=0$ to 63
- Chip Complexity: 8000 FETs or 2000 Equivalent Gates

| $\mathrm{f}_{\text {in }} \triangle$ | 28 | LD |
| :---: | :---: | :---: |
| $\mathrm{v}_{\text {S }} \mathrm{L}^{2}$ | 27 | $\mathrm{Josc}_{\text {in }}$ |
| $\mathrm{V}_{\mathrm{DD}} \mathrm{L}^{3}$ | 26 | $\mathrm{JOSC}_{\text {out }}$ |
| RAO[4 | 25 | ]4 |
| RA1[5 | 24 | A3 |
| RA2[6 | 23 | AO |
| $\phi_{R}[7$ | 22 | A2 |
| $\phi_{v}$ [8 | 21 | A1 |
| MCL9 | 20 | N9 |
| A5 10 | 19 | N8 |
| N0L11 | 18 | N7 |
| N1C12 | 17 | N6 |
| N2C13 | 16 | N5 |
| N3[14 | 15 | N4 |

Figure 5. MC145152-2 Pin Assignment

## MC145152-2 Parallel-Input (Interfaces with Dual-Modulus Prescalers)



NOTE: N0 - N9, A0 - A5, and RA0 - RA2 have pull-up resistors that are not shown.
Figure 6. MC145152-2 Block Diagram

### 2.2 Pin Descriptions

### 2.2.1 Input Pins

$f_{\text {in }}$

## Frequency Input (Pin 1)

Input to the positive edge triggered $\div \mathrm{N}$ and $\div$ A counters. $\mathrm{f}_{\text {in }}$ is typically derived from a dual-modulus prescaler and is AC coupled into the device. For larger amplitude signals (standard CMOS logic levels) DC coupling may be used.

RA0, RA1, RA2

## Reference Address Inputs (Pins 4, 5, 6)

These three inputs establish a code defining one of eight possible divide values for the total reference divider. The total reference divide values are as follows:

| Reference Address Code |  | Total <br> Divide <br> Value |  |
| :---: | :---: | :---: | :---: |
| RA2 | RA1 |  |  |
| 0 | 0 | 0 | 8 |
| 0 | 0 | 1 | 64 |
| 0 | 1 | 0 | 128 |
| 0 | 1 | 1 | 256 |
| 1 | 0 | 0 | 512 |
| 1 | 0 | 1 | 1024 |
| 1 | 1 | 0 | 1160 |
| 1 | 1 | 1 | 2048 |

```
NO - N9
N Counter Programming Inputs (Pins 11-20)
```

The N inputs provide the data that is preset into the $\div \mathrm{N}$ counter when it reaches the count of 0 . N 0 is the least significant digit and N9 is the most significant. Pull-up resistors ensure that inputs left open remain at a logic 1 and require only a SPST switch to alter data to the zero state.

```
A0 - A5
A Counter Programming Inputs
(Pins 23, 21, 22, 24, 25, 10)
```

The A inputs define the number of clock cycles of $f_{\text {in }}$ that require a logic 0 on the MC output (see Section 4.3, "Dual-Modulus Prescaling," on page 21). The A inputs all have internal pull-up resistors that ensure that inputs left open will remain at a logic 1 .

```
OSC \(_{\text {in }}\), OSC \(_{\text {out }}\)
Reference Oscillator Input/Output (Pins 27, 26)
```

These pins form an on-chip reference oscillator when connected to terminals of an external parallel resonant crystal. Frequency setting capacitors of appropriate value must be connected from $\mathrm{OSC}_{\text {in }}$ to ground and $\mathrm{OSC}_{\text {out }}$ to ground. $\mathrm{OSC}_{\text {in }}$ may also serve as the input for an externally-generated reference signal. This signal is typically ac coupled to $\mathrm{OSC}_{\mathrm{in}}$, but for larger amplitude signals (standard CMOS logic levels) dc coupling may also be used. In the external reference mode, no connection is required to OSC $_{\text {out }}$ -

### 2.2.2 Output Pins

$\phi_{\mathbf{R}}, \phi_{\mathbf{V}}$

## Phase Detector B Outputs (Pins 7, 8)

These phase detector outputs can be combined externally for a loop-error signal.
If the frequency $f_{V}$ is greater than $f_{R}$ or if the phase of $f_{V}$ is leading, then error information is provided by $\phi_{\mathrm{V}}$ pulsing low. $\phi_{\mathrm{R}}$ remains essentially high.

If the frequency $f_{V}$ is less than $f_{R}$ or if the phase of $f_{V}$ is lagging, then error information is provided by $\phi_{R}$ pulsing low. $\phi_{\mathrm{V}}$ remains essentially high.
If the frequency of $f_{V}=f_{R}$ and both are in phase, then both $\phi_{V}$ and $\phi_{R}$ remain high except for a small minimum time period when both pulse low in phase.

## MC <br> Dual-Modulus Prescale Control Output (Pin 9)

Signal generated by the on-chip control logic circuitry for controlling an external dual-modulus prescaler. The MC level will be low at the beginning of a count cycle and will remain low until the $\div$ A counter has counted down from its programmed value. At this time, MC goes high and remains high until the $\div \mathrm{N}$ counter has counted the rest of the way down from its programmed value ( N - A additional counts since both $\div \mathrm{N}$ and $\div \mathrm{A}$ are counting down during the first portion of the cycle). MC is then set back low, the counters preset to their respective programmed values, and the above sequence repeated. This provides for a total programmable divide value $\left(\mathrm{N}_{\mathrm{T}}\right)=\mathrm{N} \bullet \mathrm{P}+\mathrm{A}$ where P and $\mathrm{P}+1$ represent the dual-modulus prescaler

MC145152-2 Parallel-Input (Interfaces with Dual-Modulus Prescalers)
divide values respectively for high and low MC levels, N the number programmed into the $\div \mathrm{N}$ counter, and A the number programmed into the $\div$ A counter.

## LD

## Lock Detector Output (Pin 28)

Essentially a high level when loop is locked ( $\mathrm{f}_{\mathrm{R}}, \mathrm{f}_{\mathrm{V}}$ of same phase and frequency). Pulses low when loop is out of lock.

### 2.2.3 Power Supply

$V_{D D}$
Positive Power Supply (Pin 3)
The positive power supply potential. This pin may range from +3 to +9 V with respect to $\mathrm{V}_{\text {SS }}$.
$V_{\text {ss }}$
Negative Power Supply (Pin 2)
The most negative supply potential. This pin is usually ground.

### 2.3 Typical Applications



Figure 7. Synthesizer for Land Mobile Radio VHF Bands


Figure 8. 666-Channel Computer-Controlled, Mobile Radiotelephone Synthesizer for 800 MHz Cellular Radio Systems

## 3 MC145151-2 and MC145152-2 Electrical Characteristics

These devices contain protection circuitry to protect against damage due to high static voltages or electric fields. However, precautions must be taken to avoid applications of any voltage higher than maximum rated voltages to these high-impedance circuits. For proper operation, $\mathrm{V}_{\text {in }}$ and $\mathrm{V}_{\text {out }}$ should be constrained to the range $\mathrm{V}_{\mathrm{SS}} \leq\left(\mathrm{V}_{\text {in }}\right.$ or $\left.\mathrm{V}_{\text {out }}\right) \leq \mathrm{V}_{\mathrm{DD}}$ except for SW1 and SW2.

SW1 and SW2 can be tied through external resistors to voltages as high as 15 V , independent of the supply voltage.

Unused inputs must always be tied to an appropriate logic voltage level (e.g., either $\mathrm{V}_{\mathrm{SS}}$ or $\mathrm{V}_{\mathrm{DD}}$ ), except for inputs with pull-up devices. Unused outputs must be left open.

Table 1. Maximum Ratings ${ }^{1}$
(Voltages Referenced to VSS)

| Ratings | Symbol | Value | Unit |
| :--- | :---: | :---: | :---: |
| DC Supply Voltage | $\mathrm{V}_{\mathrm{DD}}$ | -0.5 to +10.0 | V |
| Input or Output Voltage (DC or Transient) except SW1, SW2 | $\mathrm{V}_{\text {in }}, \mathrm{V}_{\text {out }}$ | -0.5 to $\mathrm{V}_{\mathrm{DD}}+0.5$ | V |
| Output Voltage (DC or Transient), <br> SW1, SW2 ( $\left.\mathrm{R}_{\text {pull-up }}=4.7 \mathrm{k} \Omega\right)$ | $\mathrm{V}_{\text {out }}$ | -0.5 to +15 | V |
| Input or Output Current (DC or Transient), per Pin | $\mathrm{I}_{\text {in }}, \mathrm{I}_{\text {out }}$ | $\pm 10$ | mA |
| Supply Current, $\mathrm{V}_{\mathrm{DD}}$ or $\mathrm{V}_{\text {SS }}$ Pins | $\mathrm{I}_{\mathrm{DD}}, \mathrm{I}_{\mathrm{SS}}$ | $\pm 30$ | mA |
| Power Dissipation, per Package $\dagger$ | $\mathrm{P}_{\mathrm{D}}$ | 500 | mW |
| Storage Temperature | $\mathrm{T}_{\text {stg }}$ | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| Lead Temperature, 1 mm from Case for 10 seconds | $\mathrm{T}_{\mathrm{L}}$ | 260 | ${ }^{\circ} \mathrm{C}$ |

[^1]Table 2. Electrical Characteristics
(Voltages Referenced to $\mathrm{V}_{\mathrm{SS}}$ )

| Symbol | Parameter | Test Condition |  | $\mathbf{v}_{\mathrm{DD}}$ | $-40^{\circ} \mathrm{C}$ |  | $25^{\circ} \mathrm{C}$ |  | $85^{\circ} \mathrm{C}$ |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min | Max | Min | Max | Min | Max |  |
| $\mathrm{V}_{\mathrm{DD}}$ | Power Supply Voltage Range |  |  |  | - | 3 | 9 | 3 | 9 | 3 | 9 | V |
| $\mathrm{I}_{\text {ss }}$ | Dynamic Supply Current | $\begin{aligned} & \mathrm{f}_{\mathrm{in}}=\mathrm{OSC}_{\text {in }}= \\ & 1 \vee \mathrm{p}-\mathrm{p} \text { ac c } \\ & \mathrm{R}=128, \mathrm{~A}= \end{aligned}$ | MHz, d sine wave $N=128$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ |  | $\begin{gathered} 3.5 \\ 10 \\ 30 \end{gathered}$ |  | $\begin{gathered} 3 \\ 7.5 \\ 24 \end{gathered}$ |  | $\begin{gathered} \hline 3 \\ 7.5 \\ 24 \end{gathered}$ | mA |
| $I_{\text {SS }}$ | Quiescent Supply Current (not including pull-up current component) | $\begin{aligned} & \mathrm{V}_{\text {in }}=\mathrm{V}_{\mathrm{DD}} \text { or } \\ & \mathrm{I}_{\text {out }}=0 \mu \mathrm{~A} \end{aligned}$ |  | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $-$ | $\begin{gathered} \hline 800 \\ 1200 \\ 1600 \end{gathered}$ | - | $\begin{gathered} \hline 800 \\ 1200 \\ 1600 \end{gathered}$ |  | $\begin{aligned} & 1600 \\ & 2400 \\ & 3200 \end{aligned}$ | $\mu \mathrm{A}$ |
| $\mathrm{V}_{\text {in }}$ | $\begin{aligned} & \text { Input Voltage - } \mathrm{f}_{\mathrm{in}} \text {, } \\ & \text { OSC }_{\text {in }} \end{aligned}$ | Input ac coup | sine wave | - | 500 | - | 500 | - | 500 | - | mV p-p |
| $\mathrm{V}_{\mathrm{IL}}$ | Low-Level Input Voltage $-\mathrm{f}_{\mathrm{in}}, \mathrm{OSC}_{\text {in }}$ | $\begin{aligned} & \mathrm{V}_{\text {out }} \geq 2.1 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }} \geq 3.5 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }} \geq 6.3 \mathrm{~V} \end{aligned}$ | Input dc coupled square wave | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $-$ | $\begin{aligned} & 0 \\ & 0 \\ & 0 \end{aligned}$ | - | $\begin{aligned} & 0 \\ & 0 \\ & 0 \end{aligned}$ | - | $\begin{aligned} & 0 \\ & 0 \\ & 0 \end{aligned}$ | V |
| $\mathrm{V}_{\mathrm{IH}}$ | High-Level Input Voltage $-\mathrm{f}_{\mathrm{in}}, \mathrm{OSC}_{\text {in }}$ | $\begin{aligned} & \mathrm{V}_{\text {out }} \leq 0.9 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }} \leq 1.5 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }} \leq 2.7 \mathrm{~V} \end{aligned}$ | Input dc coupled square wave | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 3.0 \\ & 5.0 \\ & 9.0 \end{aligned}$ |  | $\begin{aligned} & 3.0 \\ & 5.0 \\ & 9.0 \end{aligned}$ |  | $\begin{aligned} & 3.0 \\ & 5.0 \\ & 9.0 \end{aligned}$ |  | V |
| $\mathrm{V}_{\mathrm{IL}}$ | Low-Level Input Voltage - except $f_{\text {in }}$, $\mathrm{OSC}_{\text {in }}$ |  |  | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ |  | $\begin{aligned} & 0.9 \\ & 1.5 \\ & 2.7 \end{aligned}$ | - | $\begin{aligned} & 0.9 \\ & 1.5 \\ & 2.7 \end{aligned}$ | - | $\begin{aligned} & 0.9 \\ & 1.5 \\ & 2.7 \end{aligned}$ | V |
| $\mathrm{V}_{\mathrm{IH}}$ | High-Level Input Voltage - except $\mathrm{f}_{\text {in }}$, $\mathrm{OSC}_{\text {in }}$ |  |  | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & \hline 2.1 \\ & 3.5 \\ & 6.3 \end{aligned}$ |  | $\begin{aligned} & 2.1 \\ & 3.5 \\ & 6.3 \end{aligned}$ |  | $\begin{aligned} & \hline 2.1 \\ & 3.5 \\ & 6.3 \end{aligned}$ | - | V |
| $\mathrm{I}_{\text {in }}$ | Input Current $\left(f_{i n}, O S C_{i n}\right)$ | $\mathrm{V}_{\text {in }}=\mathrm{V}_{\mathrm{DD}}$ or |  | 9 | $\pm 2$ | $\pm 50$ | $\pm 2$ | $\pm 25$ | $\pm 2$ | $\pm 22$ | $\mu \mathrm{A}$ |
| IIL | Input Leakage Current (Data, CLK, ENB - without pull-ups) | $\mathrm{V}_{\text {in }}=\mathrm{V}_{\text {SS }}$ |  | 9 | - | -0.3 | - | -0.1 | - | - 1.0 | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{H}}$ | Input Leakage Current (all inputs except $\mathrm{f}_{\mathrm{in}}$, OSC $_{\text {in }}$ ) | $\mathrm{V}_{\mathrm{in}}=\mathrm{V}_{\mathrm{DD}}$ |  | 9 | - | 0.3 | - | 0.1 | - | 1.0 | $\mu \mathrm{A}$ |

Table 3. DC Electrical Characteristics

| Symbol | Parameter | Test Condition | $\mathrm{v}_{\mathrm{DD}}$ | $-40^{\circ} \mathrm{C}$ |  | $25^{\circ} \mathrm{C}$ |  | $85^{\circ} \mathrm{C}$ |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min | Max | Min | Max | Min | Max |  |
| $\mathrm{I}_{\text {IL }}$ | Pull-up Current (all inputs with pull-ups) | $\mathrm{V}_{\text {in }}=\mathrm{V}_{\text {SS }}$ | 9 | -20 | -400 | -20 | - 200 | -20 | - 170 | $\mu \mathrm{A}$ |
| $\mathrm{C}_{\text {in }}$ | Input Capacitance |  | - | - | 10 | - | 10 | - | 10 | pF |
| $\mathrm{V}_{\mathrm{OL}}$ | Low-Level Output Voltage - OSC out | $\begin{aligned} & \mathrm{I}_{\text {out }} \approx 0 \mu \mathrm{~A} \\ & \mathrm{~V}_{\text {in }}=\mathrm{V}_{\mathrm{DD}} \end{aligned}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ |  | $\begin{aligned} & 0.9 \\ & 1.5 \\ & 2.7 \end{aligned}$ |  | $\begin{aligned} & 0.9 \\ & 1.5 \\ & 2.7 \end{aligned}$ |  | $\begin{aligned} & 0.9 \\ & 1.5 \\ & 2.7 \end{aligned}$ | V |
| $\mathrm{V}_{\mathrm{OH}}$ | High-Level Output Voltage - OSC ${ }_{\text {out }}$ | $\begin{aligned} & \mathrm{I}_{\text {out }} \approx 0 \mu \mathrm{~A} \\ & \mathrm{~V}_{\text {in }}=\mathrm{V}_{\mathrm{SS}} \end{aligned}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 2.1 \\ & 3.5 \\ & 6.3 \end{aligned}$ |  | $\begin{aligned} & 2.1 \\ & 3.5 \\ & 6.3 \end{aligned}$ |  | $\begin{aligned} & 2.1 \\ & 3.5 \\ & 6.3 \end{aligned}$ | - | V |
| $\mathrm{V}_{\mathrm{OL}}$ | Low-Level Output Voltage - Other Outputs | $\mathrm{I}_{\mathrm{out}} \approx 0 \mu \mathrm{~A}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ |  | $\begin{aligned} & 0.05 \\ & 0.05 \\ & 0.05 \end{aligned}$ |  | $\begin{aligned} & 0.05 \\ & 0.05 \\ & 0.05 \end{aligned}$ |  | $\begin{aligned} & 0.05 \\ & 0.05 \\ & 0.05 \end{aligned}$ | V |
| $\mathrm{V}_{\mathrm{OH}}$ | High-Level Output Voltage - Other Outputs | $\mathrm{I}_{\text {out }} \approx 0 \mu \mathrm{~A}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 2.95 \\ & 4.95 \\ & 8.95 \end{aligned}$ |  | $\begin{aligned} & 2.95 \\ & 4.95 \\ & 8.95 \end{aligned}$ |  | $\begin{aligned} & 2.95 \\ & 4.95 \\ & 8.95 \end{aligned}$ |  | V |
| $\mathrm{V}_{\text {(BR) } \mathrm{DSS}}$ | Drain-to-Source Breakdown Voltage SW1, SW2 | $\mathrm{R}_{\text {pull-up }}=4.7 \mathrm{k} \Omega$ | - | 15 | - | 15 | - | 15 | - | V |
| $\mathrm{l}_{\mathrm{OL}}$ | Low-Level Sinking Current - MC | $\begin{aligned} & \mathrm{V}_{\text {out }}=0.3 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=0.4 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=0.5 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 1.30 \\ & 1.90 \\ & 3.80 \end{aligned}$ |  | $\begin{aligned} & 1.10 \\ & 1.70 \\ & 3.30 \end{aligned}$ |  | $\begin{aligned} & 0.66 \\ & 1.08 \\ & 2.10 \end{aligned}$ | - | mA |
| IOH | High-Level Sourcing Current - MC | $\begin{aligned} & \mathrm{V}_{\text {out }}=2.7 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=4.6 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=8.5 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{array}{r} -0.60 \\ -0.90 \\ -1.50 \end{array}$ |  | $\begin{array}{r} -0.50 \\ -0.75 \\ -1.25 \end{array}$ |  | $\begin{array}{\|l} \hline-0.30 \\ -0.50 \\ -0.80 \end{array}$ | - | mA |
| $\mathrm{I}_{\mathrm{OL}}$ | Low-Level Sinking Current - LD | $\begin{aligned} & \mathrm{V}_{\text {out }}=0.3 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=0.4 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=0.5 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 0.25 \\ & 0.64 \\ & 1.30 \end{aligned}$ |  | $\begin{aligned} & 0.20 \\ & 0.51 \\ & 1.00 \end{aligned}$ |  | $\begin{aligned} & 0.15 \\ & 0.36 \\ & 0.70 \end{aligned}$ | - | mA |
| $\mathrm{IOH}^{\text {a }}$ | High-Level Sourcing Current - LD | $\begin{aligned} & \mathrm{V}_{\text {out }}=2.7 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=4.6 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=8.5 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{array}{r} -0.25 \\ -0.64 \\ -1.30 \end{array}$ |  | $\begin{array}{r} -0.20 \\ -0.51 \\ -1.00 \end{array}$ |  | $\begin{aligned} & -0.15 \\ & -0.36 \\ & -0.70 \end{aligned}$ | - | mA |
| $\mathrm{I}_{\mathrm{OL}}$ | Low-Level Sinking Current - SW1, SW2 | $\begin{aligned} & \mathrm{V}_{\text {out }}=0.3 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=0.4 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=0.5 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 0.80 \\ & 1.50 \\ & 3.50 \end{aligned}$ |  | $\begin{aligned} & 0.48 \\ & 0.90 \\ & 2.10 \end{aligned}$ |  | $\begin{aligned} & 0.24 \\ & 0.45 \\ & 1.05 \end{aligned}$ | - | mA |
| $\mathrm{I}_{\mathrm{OL}}$ | Low-Level Sinking Current - Other Outputs | $\begin{aligned} & \mathrm{V}_{\text {out }}=0.3 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=0.4 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=0.5 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 0.44 \\ & 0.64 \\ & 1.30 \end{aligned}$ |  | $\begin{aligned} & 0.35 \\ & 0.51 \\ & 1.00 \end{aligned}$ |  | $\begin{aligned} & 0.22 \\ & 0.36 \\ & 0.70 \end{aligned}$ | - | mA |
| IOH | High-Level Sourcing Current - Other Outputs | $\begin{aligned} & \mathrm{V}_{\text {out }}=2.7 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=4.6 \mathrm{~V} \\ & \mathrm{~V}_{\text {out }}=8.5 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{array}{r} -0.44 \\ -0.64 \\ -1.30 \end{array}$ |  | $\begin{array}{r} -0.35 \\ -0.51 \\ -1.00 \end{array}$ |  | $\begin{array}{r} -0.22 \\ -0.36 \\ -0.70 \end{array}$ | - | mA |
| $\mathrm{I}_{\mathrm{OZ}}$ | Output Leakage Current - $P D_{\text {out }}$ | $V_{\text {out }}=V_{D D}$ or $V_{S S}$ Output in Off State | 9 | - | $\pm 0.3$ | - | $\pm 0.1$ | - | $\pm 1.0$ | $\mu \mathrm{A}$ |
| $\mathrm{I}_{\mathrm{OZ}}$ | Output Leakage Current SW1, SW2 | $V_{\text {out }}=V_{D D}$ or $V_{S S}$ Output in Off State | 9 | - | $\pm 0.3$ | - | $\pm 0.1$ | - | $\pm 3.0$ | $\mu \mathrm{A}$ |
| $\mathrm{C}_{\text {out }}$ | Output Capacitance PD ${ }_{\text {out }}$ | PD ${ }_{\text {out }}$ - Three-State | - | - | 10 | - | 10 | - | 10 | pF |

## Table 4. AC Electrical Characteristics

( $\mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$, Input $\mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}}=10 \mathrm{~ns}$ )

| Symbol | Parameter | $\begin{gathered} \mathbf{v}_{\mathrm{DD}} \\ \mathbf{V} \end{gathered}$ | Guaranteed Limit $25^{\circ} \mathrm{C}$ | Guaranteed Limit $-40 \text { to } 85^{\circ} \mathrm{C}$ | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{t}_{\text {PLH }}, \mathrm{t}_{\text {PHL }}$ | Maximum Propagation Delay, $\mathrm{f}_{\text {in }}$ to MC (Figure 9a and Figure 9d) | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{gathered} \hline 110 \\ 60 \\ 35 \end{gathered}$ | $\begin{gathered} \hline 120 \\ 70 \\ 40 \end{gathered}$ | ns |
| $\mathrm{t}_{\text {PHL }}$ | Maximum Propagation Delay, ENB to SW1, SW2 (Figure 9a and Figure 9e) | $\begin{aligned} & \hline 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{gathered} \hline 160 \\ 80 \\ 50 \end{gathered}$ | $\begin{gathered} \hline 180 \\ 95 \\ 60 \end{gathered}$ | ns |
| $\mathrm{t}_{\text {w }}$ | Output Pulse Width, $\phi_{\mathrm{R}}, \phi_{\mathrm{V}}$, and LD with $\mathrm{f}_{\mathrm{R}}$ in Phase with $\mathrm{f}_{\mathrm{V}}$ (Figure 9b and Figure 9d) | $\begin{aligned} & \hline 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{gathered} 25 \text { to } 200 \\ 20 \text { to } 100 \\ 10 \text { to } 70 \end{gathered}$ | $\begin{gathered} 25 \text { to } 260 \\ 20 \text { to } 125 \\ 10 \text { to } 80 \end{gathered}$ | ns |
| $\mathrm{t}_{\text {TLH }}$ | Maximum Output Transition Time, MC (Figure 9c and Figure 9d) | $\begin{aligned} & \hline 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 115 \\ & 60 \\ & 40 \end{aligned}$ | $\begin{aligned} & \hline 115 \\ & 75 \\ & 60 \end{aligned}$ | ns |
| $\mathrm{t}_{\text {THL }}$ | Maximum Output Transition Time, MC (Figure 9c and Figure 9d) | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 60 \\ & 34 \\ & 30 \end{aligned}$ | $\begin{aligned} & 70 \\ & 45 \\ & 38 \end{aligned}$ | ns |
| $\mathrm{t}_{\text {TLH }}, \mathrm{t}_{\text {THL }}$ | Maximum Output Transition Time, LD (Figure 9c and Figure 9d) | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{gathered} 180 \\ 90 \\ 70 \end{gathered}$ | $\begin{gathered} \hline 200 \\ 120 \\ 90 \end{gathered}$ | ns |
| $\mathrm{t}_{\text {TLH }}, \mathrm{t}_{\text {THL }}$ | Maximum Output Transition Time, Other Outputs (Figure 9c and Figure 9d) | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{gathered} 160 \\ 80 \\ 60 \end{gathered}$ | $\begin{gathered} \hline 175 \\ 100 \\ 65 \end{gathered}$ | ns |



Figure 9a. Maximum Propagation Delay


Figure 9b. Output Pulse Width


Figure 9c. Maximum Output Transition Time

*Includes all probe and fixture capacitance.
Figure 9d. Test Circuit

*Includes all probe and fixture capacitance.
Figure 9e. Test Circuit

Figure 9. Switching Waveforms

MC145151-2 and MC145152-2 Technical Data, Rev. 5

## MC145151-2 and MC145152-2 Electrical Characteristics

Table 5. Timing Requirements
(Input $t_{r}=t_{f}=10 \mathrm{~ns}$ unless otherwise indicated)

| Symbol | Parameter | $\underset{\mathrm{VD}}{\mathbf{V}_{\mathrm{V}}}$ | Guaranteed Limit $25^{\circ} \mathrm{C}$ | Guaranteed Limit - 40 to $85^{\circ} \mathrm{C}$ | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{f}_{\text {clk }}$ | Serial Data Clock Frequency, Assuming 25\% Duty Cycle NOTE: Refer to CLK $\mathrm{t}_{\mathrm{w}(\mathrm{H})}$ below <br> (Figure 10a) | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | dc to 5.0 dc to 7.1 dc to 10 | dc to 3.5 dc to 7.1 dc to 10 | MHz |
| $\mathrm{t}_{\text {su }}$ | Minimum Setup Time, Data to CLK (Figure 10b) | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 30 \\ & 20 \\ & 18 \end{aligned}$ | $\begin{aligned} & 30 \\ & 20 \\ & 18 \end{aligned}$ | ns |
| $t_{\text {h }}$ | Minimum Hold Time, CLK to Data (Figure 10b) | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 40 \\ & 20 \\ & 15 \end{aligned}$ | $\begin{aligned} & 40 \\ & 20 \\ & 15 \end{aligned}$ | ns |
| $\mathrm{t}_{\text {su }}$ | Minimum Setup Time, CLK to ENB (Figure 10b) | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 70 \\ & 32 \\ & 25 \end{aligned}$ | $\begin{aligned} & 70 \\ & 32 \\ & 25 \end{aligned}$ | ns |
| $\mathrm{t}_{\text {rec }}$ | Minimum Recovery Time, ENB to CLK <br> (Figure 10b) | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{gathered} 5 \\ 10 \\ 20 \end{gathered}$ | $\begin{gathered} 5 \\ 10 \\ 20 \end{gathered}$ | ns |
| $\mathrm{t}_{\mathrm{w}(\mathrm{H})}$ | Minimum Pulse Width, CLK and ENB (Figure 10a) | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 50 \\ & 35 \\ & 25 \end{aligned}$ | $\begin{aligned} & 70 \\ & 35 \\ & 25 \end{aligned}$ | ns |
| $t_{r}, t_{f}$ | Maximum Input Rise and Fall Times - Any Input (Figure 10c) | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | $\begin{aligned} & 5 \\ & 4 \\ & 2 \end{aligned}$ | $\begin{aligned} & 5 \\ & 4 \\ & 2 \end{aligned}$ | $\mu \mathrm{S}$ |


*Assumes 25\% Duty Cycle.
Figure 10a. Serial Data Clock Frequency and Minimum Pulse Width



Figure 10b. Minimum Setup, Hold, and Recovery Times

Figure 10c. Maximum Input Rise and Fall Times
Figure 10. Switching Waveforms

Table 6. Frequency Characteristics
(Voltages References to $\mathrm{V}_{\mathrm{SS}}, \mathrm{C}_{\mathrm{L}}=50 \mathrm{pF}$, Input $\mathrm{t}_{\mathrm{r}}=\mathrm{t}_{\mathrm{f}}=10 \mathrm{~ns}$ unless otherwise indicated)

| Symbol | Parameter | Test Condition | $\mathrm{v}_{\mathrm{DD}}$ | $-40^{\circ} \mathrm{C}$ |  | $25^{\circ} \mathrm{C}$ |  | $85^{\circ} \mathrm{C}$ |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  |  |  | Min | Max | Min | Max | Min | Max |  |
| $\mathrm{f}_{\mathrm{i}}$ | Input Frequency ( $\mathrm{f}_{\mathrm{in}}, \mathrm{OSC}_{\text {in }}$ ) | $\begin{aligned} & R \geq 8, A \geq 0, N \geq 8 \\ & V_{\text {in }}=500 m V p-p \text { ac coupled } \\ & \text { sine wave } \end{aligned}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ |  | $\begin{gathered} 6 \\ 15 \\ 15 \end{gathered}$ |  | $\begin{gathered} 6 \\ 15 \\ 15 \end{gathered}$ | - | $\begin{gathered} 6 \\ 15 \\ 15 \end{gathered}$ | MHz |
|  |  | $\begin{array}{\|l} \mathrm{R} \geq 8, \mathrm{~A} \geq 0, \mathrm{~N} \geq 8 \\ \mathrm{~V}_{\text {in }}=1 \mathrm{~V} \mathrm{p}-\mathrm{p} \text { ac coupled } \\ \text { sine wave } \end{array}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ |  | $\begin{aligned} & 12 \\ & 22 \\ & 25 \end{aligned}$ | - | $\begin{aligned} & 12 \\ & 20 \\ & 22 \end{aligned}$ | - | $\begin{gathered} 7 \\ 20 \\ 22 \end{gathered}$ | MHz |
|  |  | $\begin{aligned} & \mathrm{R} \geq 8, A \geq 0, N \geq 8 \\ & V_{\text {in }}=V_{D D} \text { to } V_{S S} \text { dc coupled } \\ & \text { square wave } \end{aligned}$ | $\begin{aligned} & 3 \\ & 5 \\ & 9 \end{aligned}$ | - | $\begin{aligned} & 13 \\ & 25 \\ & 25 \end{aligned}$ | - | $\begin{aligned} & 12 \\ & 22 \\ & 25 \end{aligned}$ | - | $\begin{gathered} 8 \\ 22 \\ 25 \end{gathered}$ | MHz |

Note: Usually, the PLL's propagation delay from $f_{\text {in }}$ to MC plus the setup time of the prescaler determines the upper frequency limit of the system. The upper frequency limit is found with the following formula: $f=P /\left(t_{p}+t_{\text {set }}\right)$ where $f$ is the upper frequency in $\mathrm{Hz}, \mathrm{P}$ is the lower of the dual modulus prescaler ratios, $\mathrm{t}_{\mathrm{p}}$ is the $\mathrm{f}_{\text {in }}$ to MC propagation delay in seconds, and $\mathrm{t}_{\text {set }}$ is the prescaler setup time in seconds. For example, with a 5 V supply, the $\mathrm{f}_{\text {in }}$ to MC delay is 70 ns . If the MC12028A prescaler is used, the setup time is 16 ns . Thus, if the $64 / 65$ ratio is utilized, the upper frequency limit is $f=P /\left(t_{p}+t_{\text {set }}\right)=64 /(70+16)=744 \mathrm{MHz}$.

$\mathrm{V}_{\mathrm{H}}=$ High Voltage Level.
$\mathrm{V}_{\mathrm{L}}=$ Low Voltage Level.

* At this point, when both $f_{R}$ and $f_{V}$ are in phase, the output is forced to near mid-supply.

NOTE: The $P D_{\text {out }}$ generates error pulses during out-of-lock conditions. When locked in phase and frequency the output is high and the voltage at this pin is determined by the low-pass filter capacitor.

Figure 11. Phase Detector/Lock Detector Output Waveforms

## Design Considerations

## 4 Design Considerations

### 4.1 Phase-Locked Loop - Low-Pass Filter Design

A)


$$
\begin{aligned}
\omega_{\mathrm{n}} & =\sqrt{\frac{\mathrm{K}_{\phi} \mathrm{K}_{\mathrm{vco}}}{\mathrm{NR} \mathrm{R}_{1} \mathrm{C}}} \\
\zeta & =\frac{\mathrm{N} \omega_{\mathrm{n}}}{2 \mathrm{~K}_{\phi} \mathrm{K}_{\mathrm{vcO}}} \\
\mathrm{~F}(\mathrm{~s}) & =\frac{1}{\mathrm{R}_{1} \mathrm{SC}+1}
\end{aligned}
$$

B)

$\omega_{\mathrm{n}}=\sqrt{\frac{\mathrm{K}_{\phi} K_{\mathrm{Vco}}}{\mathrm{NC}\left(\mathrm{R}_{1}+\mathrm{R}_{2}\right)}}$

$$
\zeta=0.5 \omega_{\mathrm{n}}\left(\mathrm{R}_{2} \mathrm{C}+\frac{\mathrm{N}}{\mathrm{~K}_{\phi} \mathrm{K}_{\mathrm{vco}}}\right)
$$

$$
F(s)=\frac{R_{2} s C+1}{\left(R_{1}+R_{2}\right) s C+1}
$$



$$
\begin{aligned}
\omega_{\mathrm{n}} & =\sqrt{\frac{\mathrm{K}_{\phi} \mathrm{K}_{\mathrm{Vco}}}{\mathrm{NCR}_{1}}} \\
\zeta & =\frac{\omega_{\mathrm{n}} \mathrm{R}_{2} \mathrm{C}}{2}
\end{aligned}
$$

Assuming gain $A$ is very large, then:
$F(\mathrm{~s})=\frac{\mathrm{R}_{2} \mathrm{~s} \mathrm{C}+1}{\mathrm{R}_{1} \mathrm{sC}}$

NOTE: Sometimes $R_{1}$ is split into two series resistors, each $R_{1} \div 2$. A capacitor $C_{C}$ is then placed from the midpoint to ground to further filter $\phi_{V}$ and $\phi_{R}$. The value of $C_{C}$ should be such that the corner frequency of this network does not significantly affect $\omega_{n}$.
The $\phi_{R}$ and $\phi_{V}$ outputs swing rail-to-rail. Therefore, the user should be careful not to exceed the common mode input range of the op amp used in the combiner/loop filter.

## Definitions:

$\mathrm{N}=$ Total Division Ratio in feedback loop
$\mathrm{K}_{\phi}$ (Phase Detector Gain) $=\mathrm{V}_{\mathrm{DD}} / 4 \pi$ for $\mathrm{PD}_{\text {out }}$
$\mathrm{K}_{\phi}\left(\right.$ Phase Detector Gain) $=\mathrm{V}_{\mathrm{DD}} / 2 \pi$ for $\phi_{\mathrm{V}}$ and $\phi_{\mathrm{R}}$
$\mathrm{K}_{\mathrm{VCO}}(\mathrm{VCO}$ Gain $)=\frac{2 \pi \Delta \mathrm{f}_{\mathrm{VCO}}}{\Delta \mathrm{V}_{\mathrm{VCO}}}$
for a typical design $\mathrm{w}_{\mathrm{n}}$ (Natural Frequency) $\approx \frac{2 \pi \mathrm{fr}}{10}$ (at phase detector input).
Damping Factor: $\zeta \cong 1$

Figure 12. Phase-Locked Loop — Low-Pass Filter Design

### 4.2 Crystal Oscillator Considerations

The following options may be considered to provide a reference frequency to Freescale's CMOS frequency synthesizers.

### 4.2.1 Use of a Hybrid Crystal Oscillator

Commercially available temperature-compensated crystal oscillators (TCXOs) or crystal-controlled data clock oscillators provide very stable reference frequencies. An oscillator capable of sinking and sourcing $50 \mu \mathrm{~A}$ at CMOS logic levels may be direct or dc coupled to $\mathrm{OSC}_{\mathrm{in}}$. In general, the highest frequency capability is obtained utilizing a direct-coupled square wave having a rail-to-rail ( $\mathrm{V}_{\mathrm{DD}}$ to $\mathrm{V}_{\mathrm{SS}}$ ) voltage swing. If the oscillator does not have CMOS logic levels on the outputs, capacitive or ac coupling to OSC ${ }_{\text {in }}$ may be used. OSC $_{\text {out }}$, an unbuffered output, should be left floating.

### 4.2.2 Design an Off-Chip Reference

The user may design an off-chip crystal oscillator using ICs specifically developed for crystal oscillator applications, or using discrete transistors. The reference signal from the oscillator is ac coupled to OSC ${ }_{\text {in }}$. For large amplitude signals (standard CMOS logic levels), dc coupling is used. OSC ${ }_{\text {out }}$, an unbuffered output, should be left floating. In general, the highest frequency capability is obtained with a direct-coupled square wave having rail-to-rail voltage swing.

### 4.2.3 Use of the On-Chip Oscillator Circuitry

The on-chip amplifier (a digital inverter) along with an appropriate crystal may be used to provide a reference source frequency. A fundamental mode crystal, parallel resonant at the desired operating frequency, should be connected as shown in Figure 13.


Figure 13. Pierce Crystal Oscillator Circuit

## Design Considerations

For $\mathrm{V}_{\mathrm{DD}}=5.0 \mathrm{~V}$, the crystal should be specified for a loading capacitance, $\mathrm{C}_{\mathrm{L}}$, which does not exceed 32 pF for frequencies to approximately $8.0 \mathrm{MHz}, 20 \mathrm{pF}$ for frequencies in the area of 8.0 to 15 MHz , and 10 pF for higher frequencies. These are guidelines that provide a reasonable compromise between IC capacitance, drive capability, swamping variations in stray and IC input/output capacitance, and realistic $\mathrm{C}_{\mathrm{L}}$ values. The shunt load capacitance, $\mathrm{C}_{\mathrm{L}}$, presented across the crystal can be estimated to be:

$$
C_{L}=\frac{C_{\text {in }} C_{\text {out }}}{C_{\text {in }}+C_{\text {out }}}+C_{a}+C_{o}+\frac{C 1 \cdot C 2}{C 1+C 2}
$$

where

$$
\begin{aligned}
& \mathrm{C}_{\mathrm{in}}=5 \mathrm{pF} \text { (see Figure 14) } \\
& \mathrm{C}_{\text {out }}=6 \mathrm{pF} \text { (see Figure 14) } \\
& \mathrm{C}_{\mathrm{a}}=1 \mathrm{pF} \text { (see Figure 14) } \\
& \mathrm{C}_{\mathrm{O}}=\text { the crystal's holder capacitance (see Figure 15) }
\end{aligned}
$$

C1 and C2 $=$ external capacitors (see Figure 13)


Figure 14. Parasitic Capacitances of the Amplifier


NOTE: Values are supplied by crystal manufacturer (parallel resonant crystal).

Figure 15. Equivalent Crystal Networks
The oscillator can be "trimmed" on-frequency by making a portion or all of C1 variable. The crystal and associated components must be located as close as possible to the $\mathrm{OSC}_{\text {in }}$ and $\mathrm{OSC}_{\text {out }}$ pins to minimize distortion, stray capacitance, stray inductance, and startup stabilization time. In some cases, stray capacitance should be added to the value for $\mathrm{C}_{\mathrm{in}}$ and $\mathrm{C}_{\text {out }}$.

Power is dissipated in the effective series resistance of the crystal, $\mathrm{R}_{\mathrm{e}}$, in Figure 15. The drive level specified by the crystal manufacturer is the maximum stress that a crystal can withstand without damage or excessive shift in frequency. R1 in Figure 13 limits the drive level. The use of R1 may not be necessary in some cases (i.e., R1 $=0 \Omega$ ).

To verify that the maximum dc supply voltage does not overdrive the crystal, monitor the output frequency as a function of voltage at $\mathrm{OSC}_{\text {out }}$ (Care should be taken to minimize loading.) The frequency should increase very slightly as the dc supply voltage is increased. An overdriven crystal will decrease in frequency or become unstable with an increase in supply voltage. The operating supply voltage must be reduced or R1 must be increased in value if the overdriven condition exists. The user should note that the oscillator start-up time is proportional to the value of R1.

Through the process of supplying crystals for use with CMOS inverters, many crystal manufacturers have developed expertise in CMOS oscillator design with crystals. Discussions with such manufacturers can prove very helpful.

### 4.3 Dual-Modulus Prescaling

### 4.3.1 Overview

The technique of dual-modulus prescaling is well established as a method of achieving high performance frequency synthesizer operation at high frequencies. Basically, the approach allows relatively low-frequency programmable counters to be used as high-frequency programmable counters with speed capability of several hundred MHz . This is possible without the sacrifice in system resolution and performance that results if a fixed (single-modulus) divider is used for the prescaler.

In dual-modulus prescaling, the lower speed counters must be uniquely configured. Special control logic is necessary to select the divide value P or $\mathrm{P}+1$ in the prescaler for the required amount of time (see modulus control definition).

### 4.3.2 Design Guidelines

The system total divide value, $\mathrm{N}_{\text {total }}\left(\mathrm{N}_{\mathrm{T}}\right)$ will be dictated by the application:

$$
\mathrm{N}_{\mathrm{T}}=\frac{\text { frequency into the prescaler }}{\text { frequency into the phase detector }}=\mathrm{N} \bullet \mathrm{P}+\mathrm{A}
$$

N is the number programmed into the $\div \mathrm{N}$ counter, A is the number programmed into the $\div \mathrm{A}$ counter, P and $\mathrm{P}+1$ are the two selectable divide ratios available in the dual-modulus prescalers. To have a range of $\mathrm{N}_{\mathrm{T}}$ values in sequence, the $\div$ A counter is programmed from zero through $\mathrm{P}-1$ for a particular value N in the $\div \mathrm{N}$ counter. N is then incremented to $\mathrm{N}+1$ and the $\div \mathrm{A}$ is sequenced from 0 through $\mathrm{P}-1$ again.
There are minimum and maximum values that can be achieved for $\mathrm{N}_{\mathrm{T}}$. These values are a function of P and the size of the $\div \mathrm{N}$ and $\div \mathrm{A}$ counters.

The constraint $N \geq A$ always applies. If $A_{\max }=P-1$, then $N_{\min } \geq P-1$. Then $N_{T \min }=(P-1) P+A$ or ( $\mathrm{P}-1$ ) P since A is free to assume the value of 0 .

$$
\mathrm{N}_{\mathrm{Tmax}}=\mathrm{N}_{\max } \bullet \mathrm{P}+\mathrm{A}_{\max }
$$

To maximize system frequency capability, the dual-modulus prescaler output must go from low to high after each group of P or $\mathrm{P}+1$ input cycles. The prescaler should divide by P when its modulus control line is high and by $\mathrm{P}+1$ when its MC is low.

For the maximum frequency into the prescaler ( $\mathrm{f}_{\mathrm{VCOmax}}$ ), the value used for P must be large enough such that:

1. $f_{\text {VCOmax }}$ divided by $P$ may not exceed the frequency capability of $f_{\text {in }}$ (input to the $\div \mathrm{N}$ and $\div \mathrm{A}$ counters).
2. The period of $\mathrm{f}_{\mathrm{VCO}}$ divided by P must be greater than the sum of the times:
a) Propagation delay through the dual-modulus prescaler.
b) Prescaler setup or release time relative to its MC signal.
c) Propagation time from $\mathrm{f}_{\text {in }}$ to the MC output for the frequency synthesizer device.

A sometimes useful simplification in the programming code can be achieved by choosing the values for P of $8,16,32$, or 64 . For these cases, the desired value of $N_{T}$ results when $N_{T}$ in binary is used as the program code to the $\div \mathrm{N}$ and $\div$ A counters treated in the following manner:

1. Assume the $\div$ A counter contains " $a$ " bits where $2^{a} \geq P$.
2. Always program all higher order $\div$ A counter bits above "a" to 0 .
3. Assume the $\div \mathrm{N}$ counter and the $\div$ A counter (with all the higher order bits above "a" ignored) combined into a single binary counter of $n+a$ bits in length ( $n=$ number of divider stages in the $\div \mathrm{N}$ counter). The MSB of this "hypothetical" counter is to correspond to the MSB of $\div \mathrm{N}$ and the LSB is to correspond to the LSB of $\div \mathrm{A}$. The system divide value, $\mathrm{N}_{\mathrm{T}}$, now results when the value of $\mathrm{N}_{\mathrm{T}}$ in binary is used to program the "new" $\mathrm{n}+\mathrm{a}$ bit counter.

By using the two devices, several dual-modulus values are achievable.

## 5 Package Dimensions



Figure 16. Outline Dimensions for Plastic DIP
(Case Outline 710-02, Issue B)

DW SUFFIX SOG PACKAGE


1. DIMENSIONS ARE IN MILLIMETERS.
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M, 1994.
PROTRUSIONS.
3. MAXIMUM MOLD PROTRUSION 0.015 PER SIDE.
4. DIMENSION B DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.13 TOTAL IN EXCESS OF B DIMENSION AT MAXIMUM MATERIAL CONDITION.

|  | MILLIMETERS |  |
| :---: | ---: | ---: |
| DIM | MIN | MAX |
| A | 2.35 | 2.65 |
| A1 | 0.13 | 0.29 |
| B | 0.35 | 0.49 |
| $\mathbf{C}$ | 0.23 | 0.32 |
| $\mathbf{D}$ | 17.80 | 18.05 |
| E | 7.40 | 7.60 |
| $\mathbf{e}$ | 1.27 | BSC |
| $\mathbf{H}$ | 10.05 | 10.55 |
| $\mathbf{L}$ | 0.41 | 0.90 |
| $\theta$ | $0^{\circ}$ | $8^{\circ}$ |

Figure 17. Outline Dimensions for SOG Package
(Case Outline 751F-05, Issue F)

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[^0]:    Freescale reserves the right to change the detail specifications as may be required to permit improvements in the design of its products.

[^1]:    ${ }^{1}$ Maximum Ratings are those values beyond which damage to the device may occur. Functional operation should be restricted to the limits in the Electrical Characteristics tables or Pin Descriptions section.
    $\dagger$ Power Dissipation Temperature Derating:
    Plastic DIP: - $12 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ from 65 to $85^{\circ} \mathrm{C}$
    SOG Package: $-7 \mathrm{~mW} /{ }^{\circ} \mathrm{C}$ from 65 to $85^{\circ} \mathrm{C}$

